

**Notice of References Cited**

Application/Control No.

10/565,555

Applicant(s)/Patent Under  
Reexamination  
HAYASHI ET AL.

Examiner

Vu Nguyen

Art Unit

1796

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0055178 A1	03-2003	Gore et al.	525/242
*	B	US-6,652,634 B1	11-2003	Akers et al.	106/31.13
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	D	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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